



# RF EXPOSURE REPORT

Report No.: 20250117G01666X-W11

Product Name: KEY TOOL MIDI

Model No.: XDKMD

FCC ID: 2AI4T-XDKMD

**Applicant:** Shenzhen Xhorse Electronics Co., Ltd.

Address: Floor 28, Block A, Building NO.6, International Innovation Valley,

Nanshan District, Shenzhen

**Dates of Testing:** 01/27/2025–04/11/2025

Issued by: CCIC Southern Testing Co., Ltd.

Lab Location: Electronic Testing Building, No.43, Shahe Road, Xili Street,

Nanshan District, Shenzhen, Guangdong, China.

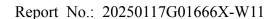
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### **Test Report**

Product.....: KEY TOOL MIDI

Trade Name .....: Xhorse

Applicant.....: Shenzhen Xhorse Electronics Co., Ltd.

Applicant Address...... Floor 28, Block A, Building NO.6, International Innovation

Valley, Nanshan District, Shenzhen

Manufacturer.....: Shenzhen Xhorse Electronics Co., Ltd.

Manufacturer Address.....: Floor 28, Block A, Building NO.6, International Innovation

Valley, Nanshan District, Shenzhen

Test Standards.....: 47 CFR Part 2.1093

Test Result.....: Pass

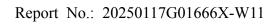
Chuiwang Zhang, Test Engineer

Reviewed by Sun Jidohui 2025.04.11

Sun Jiaohui, Senior Engineer

Approved by.....: 2025.04.11

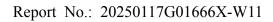
Chris You, Manager





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| Change History |                              |               |  |  |
|----------------|------------------------------|---------------|--|--|
| Issue          | Issue Date Reason for change |               |  |  |
| 1.0            | 2025.04.11                   | First edition |  |  |
|                |                              |               |  |  |



### 1. GENERAL INFORMATION

## 1.1. EUT Description

| Product Name                    | KEY TOOL MIDI              |  |  |
|---------------------------------|----------------------------|--|--|
| Device Type                     | Portable Device            |  |  |
| EUT supports Radios application | NFC                        |  |  |
|                                 | 13.553–13.567 MHz          |  |  |
| Frequency Range                 | 22 kHz; 125 kHz            |  |  |
|                                 | 315 MHz, 433 MHz           |  |  |
| Modulation Type                 | ASK                        |  |  |
| Antenna gain                    | 13.56 MHz: 2.0 dBi         |  |  |
|                                 | 22 kHz & 125 kHz: 2.0 dBi  |  |  |
|                                 | 315 MHz & 433 MHz: 3.0 dBi |  |  |
| Antenna Type                    | Internal Antenna           |  |  |

Note 1: The information of antenna gain and cable loss is provided by the manufacturer and our lab is not responsible for the accuracy of the antenna gain and cable loss information.



#### 1.2. EUT Description

EUT has been tested according to the following standards.

| No. | Identity  | Document Title  |  |  |
|-----|---|---|--|--|
| 1   | 47 CFR Part 1   | Practice and Procedure  |  |  |
| 2   | 47 CFR Part 2   | Frequency Allocations and Radio Treaty Matters; General Rules and Regulations |  |  |
| 3   | 3 KDB 447498 D01 General RF Exposure Procedures and Equipment Author Policies for Mobile and Portable Devices |   |  |  |

### 1.3. Laboratory Facilities and Accreditation Certificate

#### **◯ CCIC-SET Lab 1**

Address: Electronic Testing Building, No.43, Shahe Road, Xili Street, Nanshan District, Shenzhen, Guangdong, China

#### FCC-Registration No.: CN1283

CCIC Southern Testing Co., Ltd EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Designation Number: CN1283, valid time is until Jun. 30th, 2025.

#### ISED Registration: 11185A, CAB number: CN0064

CCIC Southern Testing Co., Ltd. EMC Laboratory has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No. 11185A on Aug. 04, 2016, valid time is until Jun. 30th, 2025.

#### **A2LA Code: 5721.01**

CCIC-SET is a third party testing organization accredited by A2LA according to ISO/IEC 17025. The accreditation certificate number is 5721.01.

#### **CNAS L1659**

CCIC Southern Testing Co., Ltd. CCIC is a third party testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L1659.

#### CCIC-SET Lab 4

Address: No.125, Hongmei Section, Wangsha Road, Hongmei Town, Dongguan City, Guangdong Province, China

#### **CNAS L1659**

CCIC Southern Testing Co., Ltd. CCIC is a third party testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L1659.



### 2. Technical Requirements Specification in CFR Title 47 Part 2.1093

#### 2.1. Evaluation method

According to KDB 447498 D01 General RF Exposure Guidance v06, clause 4.3. General SAR test exclusion guidance:

- c) For frequencies below 100 MHz, the following may be considered for SAR test exclusion (also illustrated in Appendix C):
  - 1) For test separation distances > 50 mm and < 200 mm, the power threshold at the corresponding test separation distance at 100 MHz in step b) is multiplied by  $[1 + \log(100/f_{\text{(MHz)}})]$
  - 2) For test separation distances  $\leq$  50 mm, the power threshold determined by the equation in c) 1) for 50 mm and 100 MHz is multiplied by  $\frac{1}{2}$
  - 3) SAR measurement procedures are not established below 100 MHz.

#### 2.2. Evaluation Results

| Frequency | Field strength    | Radiated Power | Conducted power | Exclusion Threshold |
|-----------|-------------------|----------------|-----------------|---------------------|
| (MHz)     | $(dB\mu V/m@3 m)$ | (EIRP)(mW)     | (mW)            | Level (mW)          |
| 13.56     | 10.50             | 0              | 0               | 21.77               |
| 0.022     | 53.22             | 0              | 0               | 21.77               |
| 0.125     | 40.50             | 0              | 0               | 21.77               |

#### Notes:

Conducted power = Radiated Power (EIRP) - Antenna Gain.

 $EIRP[dBm] = E[dB\mu V/m] - 95.2 = 10.50 dB\mu V/m - 95.2 = -84.70 dBm \approx 0 mW.$ 

 $EIRP[dBm] = E[dB\mu V/m] - 95.2 = 53.22 dB\mu V/m - 95.2 = -41.98 dBm \approx 0 mW.$ 

 $EIRP[dBm] = E[dB\mu V/m] - 95.2 = 40.50 dB\mu V/m - 95.2 = -54.70 dBm \approx 0 mW.$ 

Exclusion Threshold Level =  $474^{\frac{1}{2}}$  = 21.77 mW.



### 2.3. Conclusion

Since the source-based time-averaging conducted output power is well below the SAR low threshold level, so the EUT is considered to comply with SAR requirement without testing.

\*\* END OF REPORT \*\*